
PXle-4480

Specifications

2024-09-12



Contents

PXIe-4480 Specifications 3

PXIe-4480 Specifications

Definitions

Warranted specifications describe the performance of a model under stated operating conditions and are covered by the model warranty.

Characteristics describe values that are relevant to the use of the model under stated operating conditions but are not covered by the model warranty.

- **Typical** specifications describe the performance met by a majority of models.
- **Nominal** specifications describe an attribute that is based on design, conformance testing, or supplemental testing.

Specifications are **Typical** unless otherwise noted.

Conditions

Specifications are valid for the range 0 °C to 55 °C unless otherwise noted.

Input Characteristics

Number of simultaneously sampled input channels	6
Measurement types	Voltage or Charge, each channel independently software-selectable
Input configuration	
Voltage	Differential or pseudodifferential (50 Ω between negative input and chassis ground), each

	channel independently software-selectable
Charge	Single-ended (negative input grounded)
Input coupling	
Voltage	AC or DC, each channel independently software-selectable
Charge	AC

A/D converter (ADC) resolution	24 bits
ADC type	Delta-Sigma
Sample rates (f_s)	
Range	100 Sample/s to 1.25 MSample/s
Resolution ¹	≤ 1.458 mSample/s

ADC modulator sample rate	20 MSample/s
FIFO buffer size	1,023 samples per task + 8,221 samples per channel in task
Data transfers	Direct Memory Access (DMA), Programmed I/O

1. Dependent on the sample rate. Refer to the **PXIe-4480/4481 User Manual** for more information.

Common-Mode Range (Voltage)

Input	Configuration	
	Differential (V peak) *	Pseudodifferential (V peak) *
Positive input (+)	±10	±10
Negative input (-)	±10	±10

* Voltages with respect to chassis ground.

Signal Range (Voltage)

Range (V) *	Full-Scale Input, Minimum	
	V peak	V RMS †
10	±10.0‡	7.07‡
5	±5.0	3.53
1	±1.0	0.707
0.5	±0.5	0.353

* Each input channel range is independently software-selectable.

† Sine input.

‡ Typical.

Signal Range (Charge)

Range (pC) *	Full-Scale Input, Minimum	
	Q peak (pC)	Q RMS (pC) †
20,000	±20,000‡	14,140‡
10,000	±10,000	7,070
2,000	±2,000	1,414

Range (pC) *	Full-Scale Input, Minimum	
	Q peak (pC)	Q RMS (pC) †
1,000	±1,000	707

* Each input channel range is independently software-selectable.

† Sine input.

‡ Typical.

Overvoltage Protection (Voltage)

Input	Configuration	
	Differential (V peak) *	Pseudodifferential (V peak) *
Positive input (+)	±30	±30
Negative input (-)	±30	±10

* Voltages with respect to chassis ground.

Overvoltage Protection (Charge)

Input	Voltage (V peak) *
Positive input (+)	±15
Negative input (-)	None

* Voltages with respect to chassis ground.

Overvoltage Protection (Unpowered)

Input	Voltage (V peak) *
Positive input (+)	±15
Negative input (-)	±15

* Voltages with respect to chassis ground.

Transfer Characteristics

Offset (Residual DC)

Range (V)	DC-Coupled Offset (±mV) *, Maximum (Typical)	AC-Coupled Offset (±mV) †, Typical, 25 °C	AC-Coupled Offset (±mV) †, Maximum, 55 °C
10	5.0 (2.0)	1.1	7.0
5	2.2 (1.0)	0.6	5.0
1	0.8 (0.5)	0.3	4.2
0.5	0.65 (0.4)	0.3	4.2

* Source impedance ≤ 50 Ω.

† Applied DC bias ≤ 15 V.

Gain Amplitude Accuracy

Voltage	
1 kHz input tone	±0.05 dB maximum, ±0.02 dB typical
Charge	

1 kHz input tone	± 0.1 dB maximum, ± 0.06 dB typical
------------------	---

Amplifier Characteristics

Input Impedance (Voltage)

Input Impedance	Configuration	
	Differential	Pseudodifferential
Between positive input and chassis ground	$1.62 \text{ M}\Omega \parallel 200 \text{ pF}$	$1.62 \text{ M}\Omega \parallel 200 \text{ pF}$
Between negative input and chassis ground	$1.62 \text{ M}\Omega \parallel 200 \text{ pF}$	50Ω

Common-Mode Rejection Ratio (CMRR)

Range (V)	DC-Coupled CMRR (dBc) ^{*,†}	AC-Coupled CMRR (dBc) ^{*,‡}
10	60	60
5	70	70
1	85	80
0.5	90	80

* $f_{in} \leq 1 \text{ kHz}$.

† Differential configuration.

‡ $f_{in} = 50 \text{ Hz}$ or 60 Hz .

Dynamic Characteristics

Bandwidth and Alias Rejection

Alias-free bandwidth (BW) (passband)	DC to $0.403 f_s$
Alias rejection	120 dBc minimum, $0.597 f_s < f_{in} < 19.25375 \text{ MHz}$

Filter Delay

Digital filter delay	Adjustable ²
Analog filter delay	
10 V range	31 ns
5 V range	47 ns
1 V range	150 ns
0.5 V range	215 ns

AC Coupling (Voltage)

-3 dB cutoff frequency	0.49 Hz
------------------------	---------

2. Digital filter delay is compensated to 0 ns by default and adjustable in software.

-0.1 dB cutoff frequency	3.2 Hz
--------------------------	--------

Figure 1. AC-Coupled Voltage Measurement Magnitude Response vs. Frequency

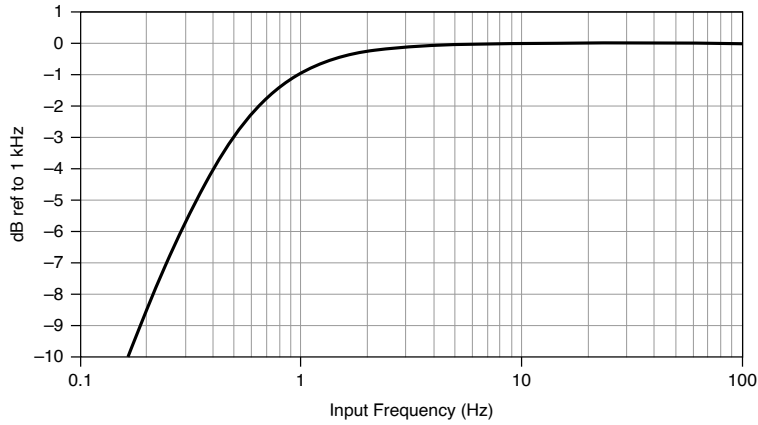
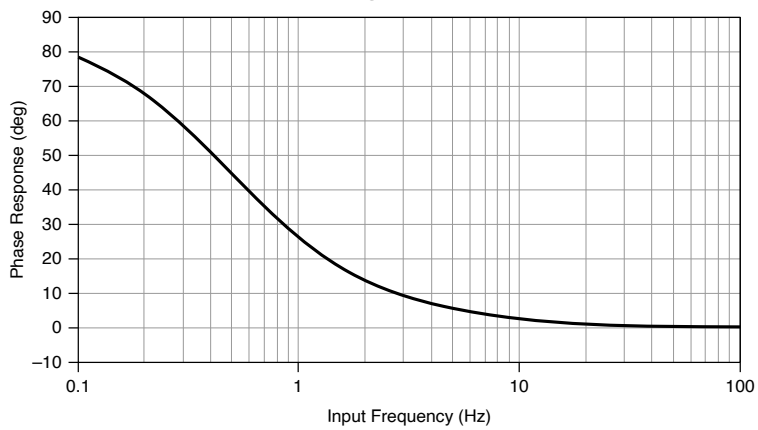
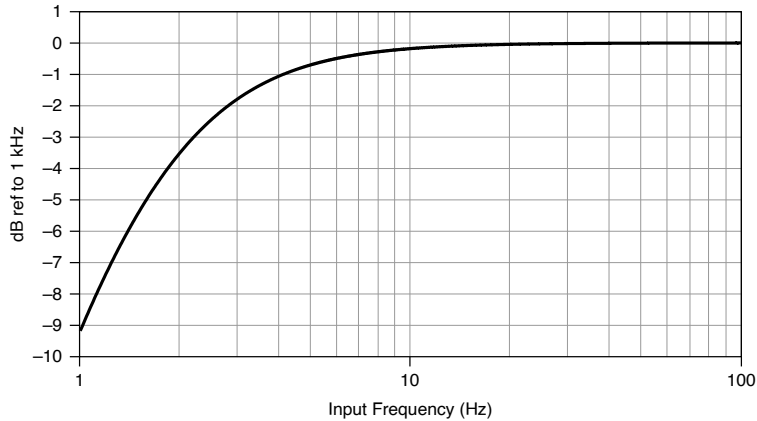


Figure 2. AC-Coupled Voltage Measurement Phase Response vs. Frequency



AC Coupling (Charge)

-3 dB cutoff frequency	2.2 Hz
-0.1 dB cutoff frequency	13.5 Hz

Figure 3. Charge Measurement Magnitude Response vs. Frequency

Gain Flatness (Voltage)

Range (V)	$f_s = 1.25 \text{ MSamples/s}$				
	DC-Coupled Flatness (dB) [*] , Maximum (Typical)				
	$f_{in} = 20 \text{ Hz to } 20 \text{ kHz}$	$f_{in} > 20 \text{ kHz to } 50 \text{ kHz}$	$f_{in} > 50 \text{ kHz to } 100 \text{ kHz}$	$f_{in} > 100 \text{ kHz to } 200 \text{ kHz}$	$f_{in} > 200 \text{ kHz to } 500 \text{ kHz}$
10	$\pm 0.007 (\pm 0.001)$	$\pm 0.013 (\pm 0.003)$	$\pm 0.03 (\pm 0.003)$	$\pm 0.11 (\pm 0.005)$	(± 0.025)
5	$\pm 0.007 (\pm 0.001)$	$\pm 0.013 (\pm 0.003)$	$\pm 0.03 (\pm 0.0035)$	$\pm 0.11 (\pm 0.0055)$	(± 0.04)
1	$\pm 0.007 (\pm 0.001)$	$\pm 0.016 (\pm 0.004)$	$\pm 0.057 (\pm 0.022)$	$\pm 0.22 (\pm 0.1)$	(± 0.6)
0.5	$\pm 0.008 (\pm 0.002)$	$\pm 0.025 (\pm 0.012)$	$\pm 0.094 (\pm 0.055)$	$\pm 0.36 (\pm 0.23)$	(± 1.25)

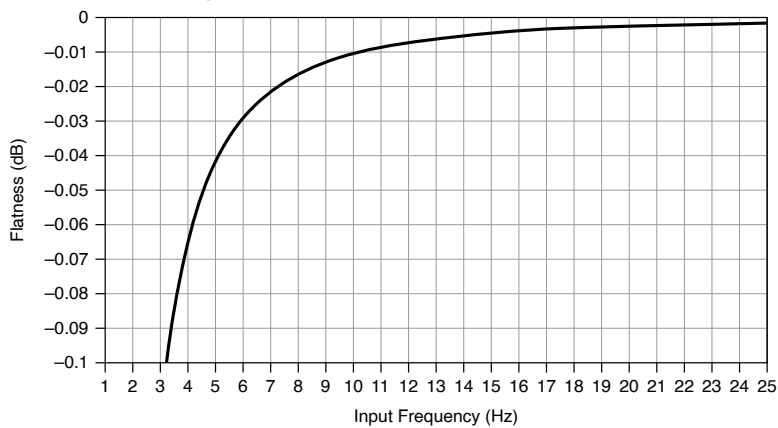
^{*} Relative to 1 kHz.

Range (V)	$f_s = 1.25 \text{ MSamples/s}$					
	AC-Coupled Flatness (dB) [*] , Maximum (Typical)					
	$f_{in} \leq 25 \text{ Hz}$	$f_{in} > 25 \text{ Hz to } 20 \text{ kHz}$	$f_{in} > 20 \text{ kHz to } 50 \text{ kHz}$	$f_{in} > 50 \text{ kHz to } 100 \text{ kHz}$	$f_{in} > 100 \text{ kHz to } 200 \text{ kHz}$	$f_{in} > 200 \text{ kHz to } 500 \text{ kHz}$
10	Refer to the following figure.	$\pm 0.007 (\pm 0.001)$	$\pm 0.013 (\pm 0.003)$	$\pm 0.03 (\pm 0.003)$	$\pm 0.11 (\pm 0.005)$	(± 0.025)
5	Refer to the following	$\pm 0.007 (\pm 0.001)$	$\pm 0.013 (\pm 0.003)$	$\pm 0.03 (\pm 0.0035)$	$\pm 0.11 (\pm 0.0055)$	(± 0.04)

Range (V)	$f_s = 1.25 \text{ MSamples/s}$					
	AC-Coupled Flatness (dB) [*] , Maximum (Typical)					
	$f_{in} \leq 25 \text{ Hz}$	$f_{in} > 25 \text{ Hz}$ to 20 kHz	$f_{in} > 20 \text{ kHz}$ to 50 kHz	$f_{in} > 50 \text{ kHz}$ to 100 kHz	$f_{in} > 100 \text{ kHz}$ to 200 kHz	$f_{in} > 200 \text{ kHz}$ to 500 kHz
	figure.					
1	Refer to the following figure.	± 0.007 (± 0.001)	± 0.016 (± 0.004)	± 0.057 (± 0.022)	± 0.22 (± 0.1)	(± 0.6)
0.5	Refer to the following figure.	± 0.008 (± 0.002)	± 0.025 (± 0.012)	± 0.094 (± 0.055)	± 0.36 (± 0.23)	(± 1.25)

^{*} Relative to 1 kHz.

Figure 4. Voltage Measurement AC-Coupled Gain Flatness



Gain Flatness (Charge)

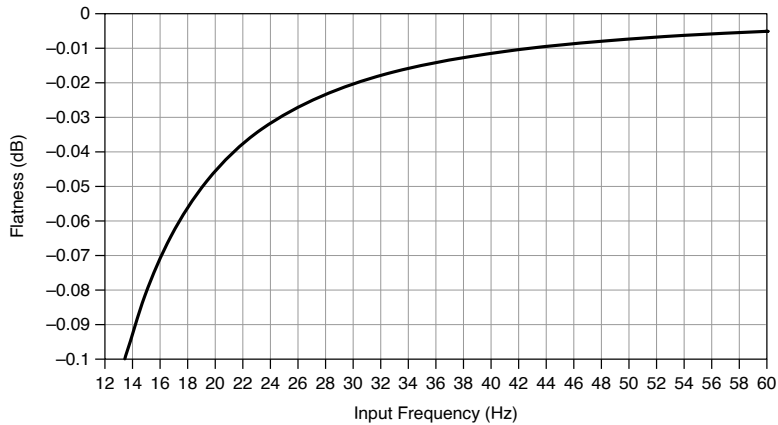
Range (pC)	$f_s = 1.25 \text{ MSample/s}$					
	Flatness (dBc) ^{*,†}					
	$f_{in} \leq 60 \text{ Hz}$	$f_{in} > 60 \text{ Hz}$ to 20 kHz	$f_{in} > 20 \text{ kHz}$ to 50 kHz	$f_{in} > 50 \text{ kHz}$ to 100 kHz	$f_{in} > 100 \text{ kHz}$ to 200 kHz	$f_{in} > 200 \text{ kHz}$ to 500 kHz
20,000	Refer to the following	± 0.001	± 0.003	± 0.003	± 0.005	± 0.025

Range (pC)	$f_s = 1.25 \text{ MSample/s}$					
	Flatness (dBc) ^{*,†}					
	$f_{in} \leq 60 \text{ Hz}$	$f_{in} > 60 \text{ Hz}$ to 20 kHz	$f_{in} > 20 \text{ kHz}$ to 50 kHz	$f_{in} > 50 \text{ kHz}$ to 100 kHz	$f_{in} > 100 \text{ kHz}$ to 200 kHz	$f_{in} > 200 \text{ kHz}$ to 500 kHz
	figure.					
10,000	Refer to the following figure.	±0.001	±0.003	±0.0035	±0.0055	±0.04
2,000	Refer to the following figure.	±0.001	±0.004	±0.022	±0.1	±0.6
1,000	Refer to the following figure.	±0.002	±0.012	±0.055	±0.23	±1.25
<p>* Relative to 1 kHz.</p> <p>† Charge filter OFF.</p>						

Charge Measurement Filter

OFF	None
ON	2nd order, 30 kHz low-pass filter

Figure 5. Charge Measurement Gain Flatness



Interchannel Gain Mismatch (Voltage)

Range (V)	AC/DC-Coupled Mismatch (dB) *, Maximum, (Typical)			AC-Coupled Mismatch (dB) *, Maximum (Typical)	
	$f_{in} = 20 \text{ Hz to } 20 \text{ kHz}$	$f_{in} > 20 \text{ kHz to } 50 \text{ kHz}$	$f_{in} > 50 \text{ kHz to } 100 \text{ kHz}$	$f_{in} = 5 \text{ Hz}$	$f_{in} = 10 \text{ Hz}$
10	0.011 (0.005)	0.011 (0.005)	0.011 (0.005)	0.019 (0.009)	0.015 (0.007)
5	0.013 (0.006)	0.013 (0.006)	0.013 (0.006)		
1	0.015 (0.007)	0.015 (0.007)	0.019 (0.009)		
0.5	0.015 (0.007)	0.017 (0.008)	0.034 (0.017)		

* Identical channel configurations.

Interchannel Phase Mismatch (Voltage)

Range (V)	AC/DC-Coupled Mismatch *, Maximum, (Typical)			AC-Coupled Mismatch *, Maximum (Typical)	
	$f_{in} = 20 \text{ Hz to } 20 \text{ kHz}$	$f_{in} > 20 \text{ kHz to } 50 \text{ kHz}$	$f_{in} > 50 \text{ kHz to } 100 \text{ kHz}$	$f_{in} = 5 \text{ Hz}$	$f_{in} = 10 \text{ Hz}$
10	0.02° (0.01°)	0.05° (0.025°)	0.1° (0.05°)	0.34° (0.17°)	0.17° (0.09°)
5	0.04° (0.02°)	0.10° (0.05°)	0.2° (0.1°)		
1	0.24° (0.12°)	0.60° (0.30°)	1.2° (0.6°)		
0.5	0.38° (0.19°)	0.96° (0.48°)	1.9° (0.95°)		

Range (V)	AC/DC-Coupled Mismatch [*] , Maximum, (Typical)			AC-Coupled Mismatch [*] , Maximum (Typical)	
	$f_{in} = 20 \text{ Hz to } 20 \text{ kHz}$	$f_{in} > 20 \text{ kHz to } 50 \text{ kHz}$	$f_{in} > 50 \text{ kHz to } 100 \text{ kHz}$	$f_{in} = 5 \text{ Hz}$	$f_{in} = 10 \text{ Hz}$
* Identical channel configurations.					



Note Listed gain and phase mismatch specifications are valid for measurements made on channels on the same module. For measurements made on channels on different modules, the listed gain and phase mismatch specifications still apply, but are subject to the following conditions:

- For gain matching, all modules must be properly warmed up. Refer to the Environmental section for the specified warm-up time.
- For phase matching, all modules must be synchronized to a common timebase. To the listed specifications, add the following error: $360^\circ \times f_{in} \times \text{clock skew}$. Refer to the Timing and Synchronization section for the maximum intermodule clock skew.

Idle Channel Noise (Voltage)

Range (V)	Idle Channel Noise ($\mu\text{V RMS}$) [*]		
	$f_s = 51.2 \text{ kSample/s}$	$f_s = 204.8 \text{ kSample/s}$	$f_s = 1.25 \text{ MSample/s}$
10	16	32	87
5	6.5	13	35
1	1.8	3.6	9.1
0.5	1.5	3.0	7.1

* Source impedance $\leq 50 \Omega$.

Dynamic Range (Voltage)

Range (V)	Dynamic Range (dBFS) ^{*, †}		
	$f_s = 51.2 \text{ kSample/s}$	$f_s = 204.8 \text{ kSample/s}$	$f_s = 1.25 \text{ MSample/s}$
10	113	107	98
5	115	109	100
1	112	106	98
0.5	107	101	94

* 1 kHz tone, -60 dBFS input amplitude.

† Source impedance $\leq 50 \Omega$.

Idle Channel Noise (Charge)

Range (pC)	Idle Channel Noise (f_C RMS) [*]		
	$f_s = 51.2 \text{ kSample/s}$	$f_s = 204.8 \text{ kSample/s}$	$f_s = 1.25 \text{ MSample/s}$
20,000	32	64	174
10,000	16	30	75
2,000	13	18	25
1,000	13	18	25

* Charge filter OFF.

Representative Measurement FFTs (1 kHz)

Test conditions for all FFTs: Unaveraged computation of 1.6 million samples, differential input configuration.

Figure 6. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 10 V Range (Full Bandwidth)

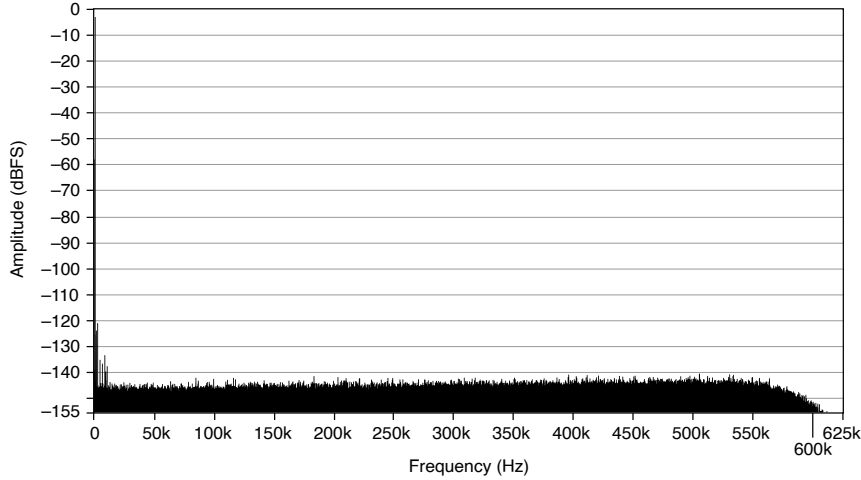


Figure 7. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 10 V Range (20 kHz Bandwidth)

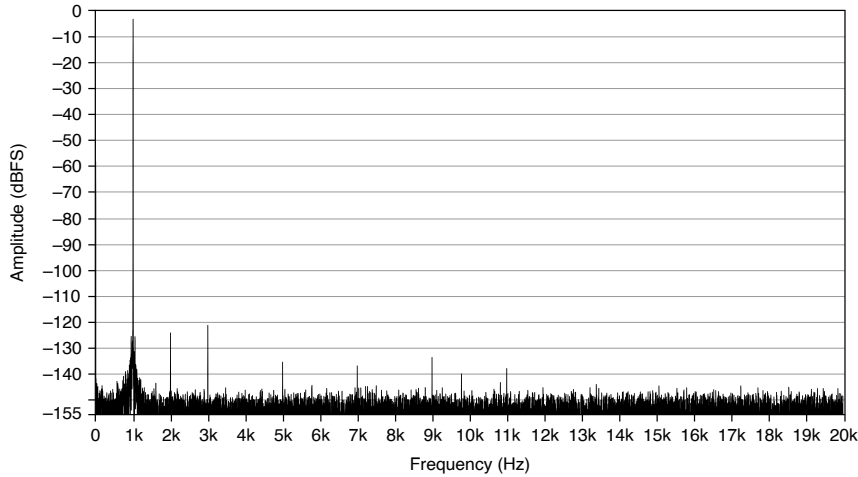


Figure 8. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 5 V Range (Full Bandwidth)

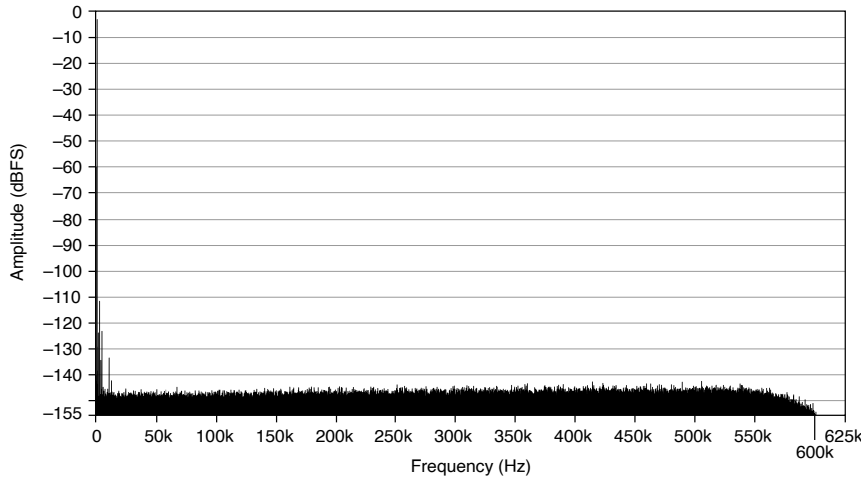


Figure 9. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 5 V Range (20 kHz Bandwidth)

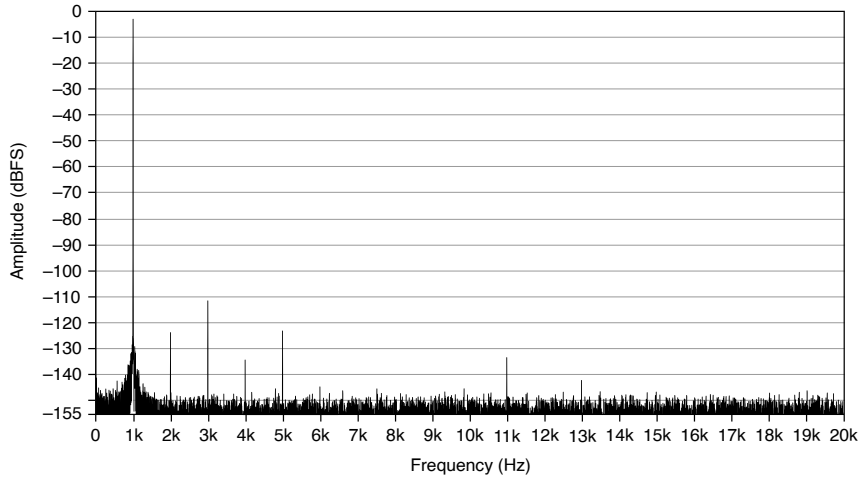


Figure 10. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 1 V Range (Full Bandwidth)

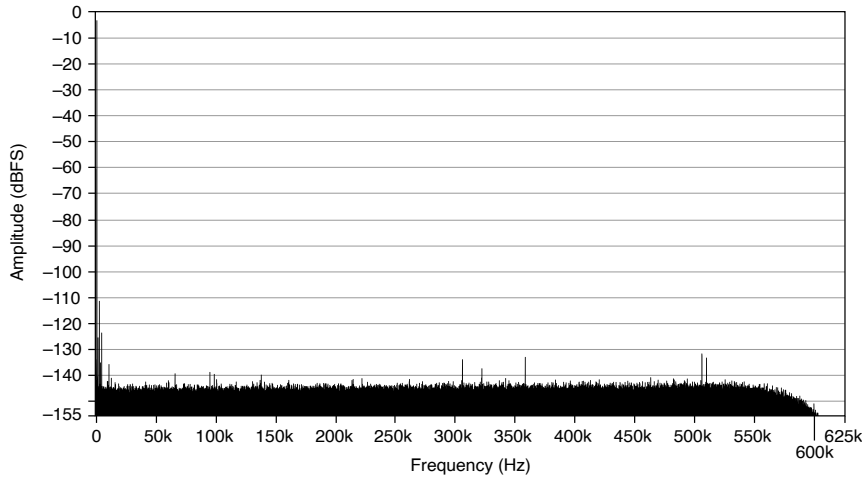


Figure 11. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 1 V Range (20 kHz Bandwidth)

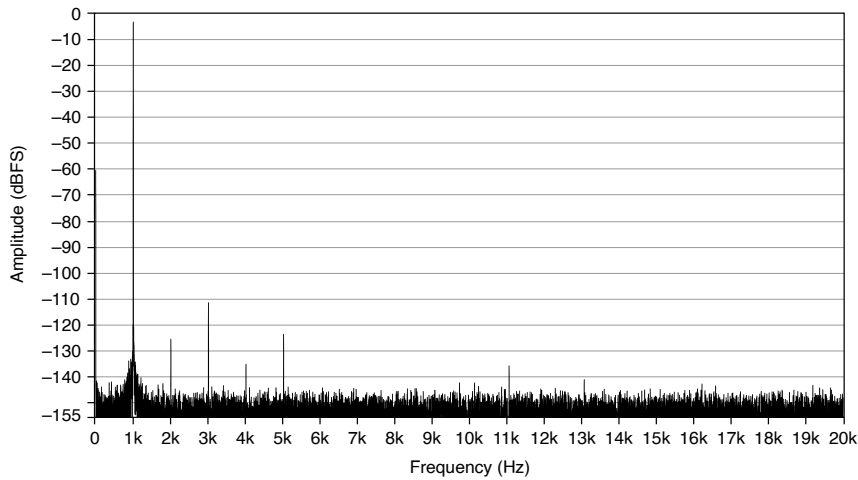
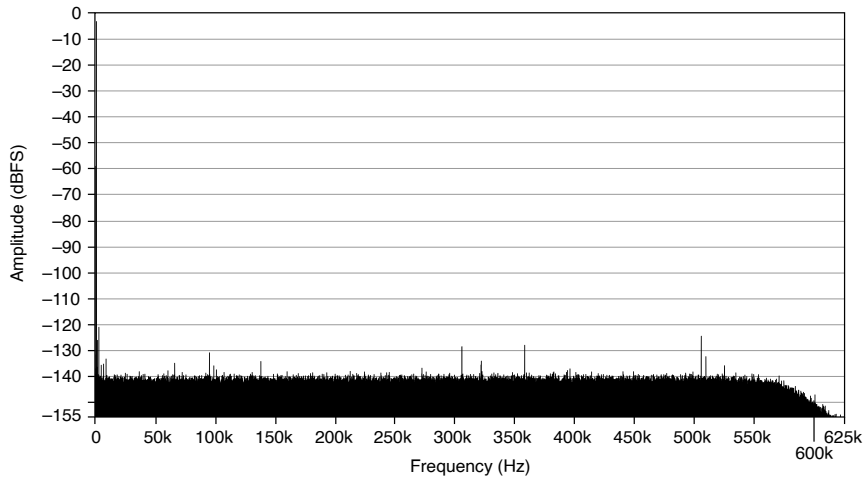
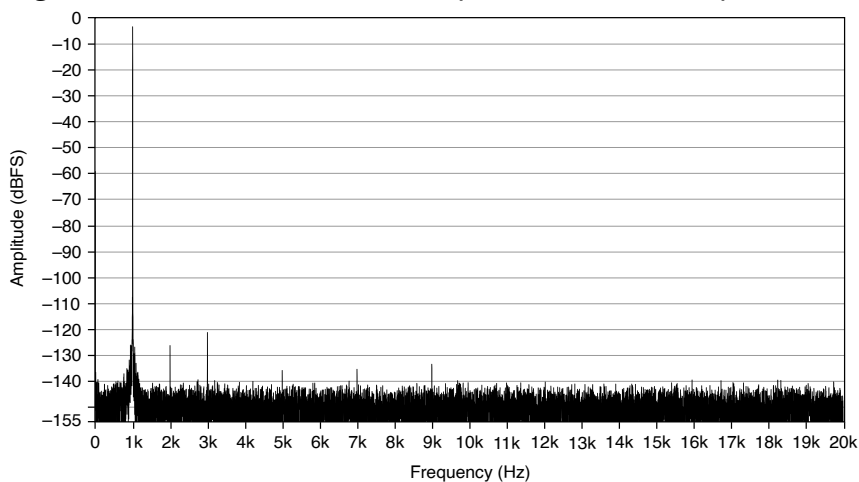


Figure 12. -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 0.5 V Range (Full Bandwidth)**Figure 13.** -3 dBFS, 1 kHz Tone Acquired at 1.25 MSample/s, 0.5 V Range (20 kHz Bandwidth)

Representative Measurement FFTs (10 kHz)

Test conditions for all FFTs: Unaveraged computation of 1.6 million samples, differential input configuration.

Figure 14. -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 10 V Range (Full Bandwidth)

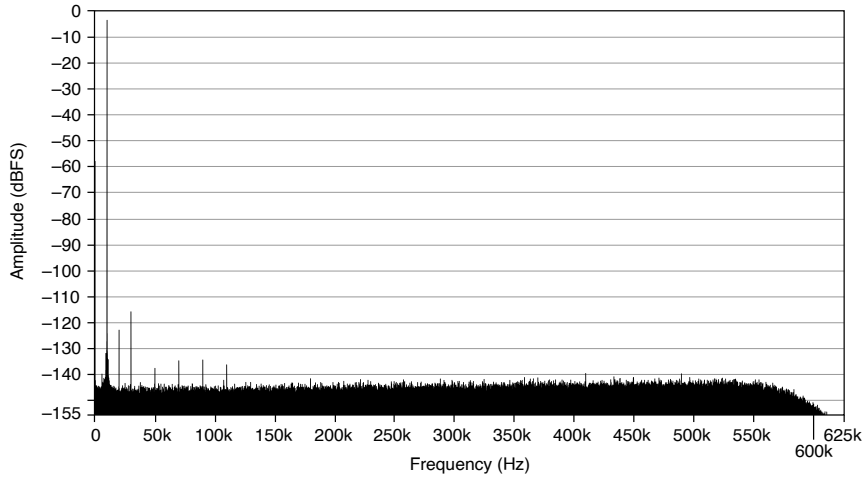


Figure 15. -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 10 V Range (150 kHz Bandwidth)

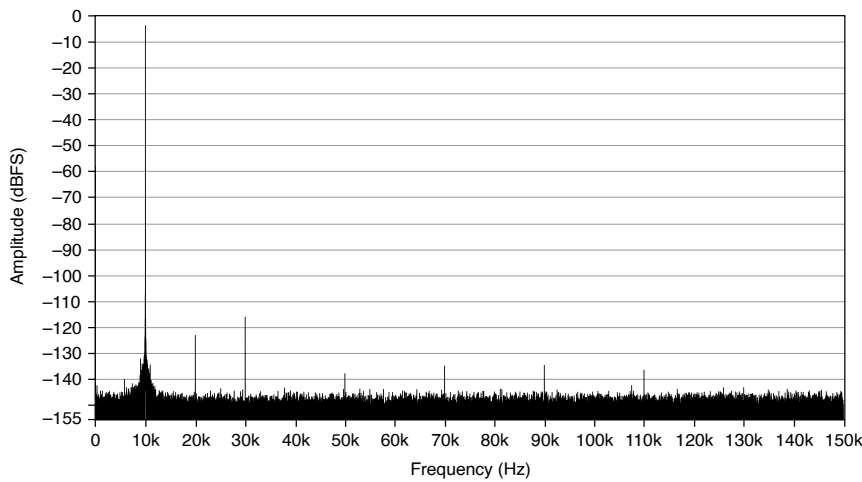


Figure 16. -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 5 V Range (Full Bandwidth)

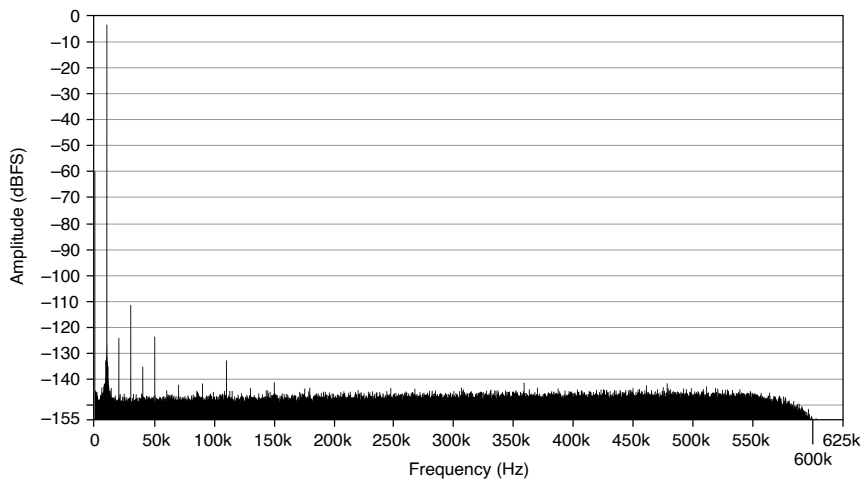


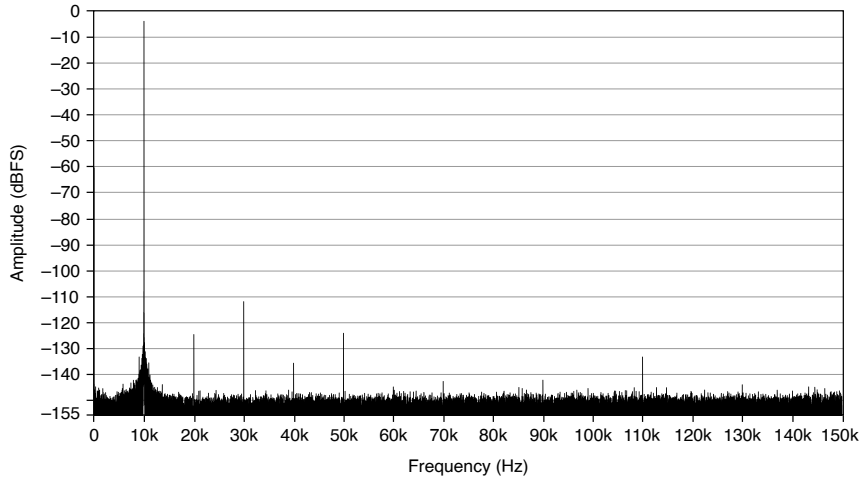
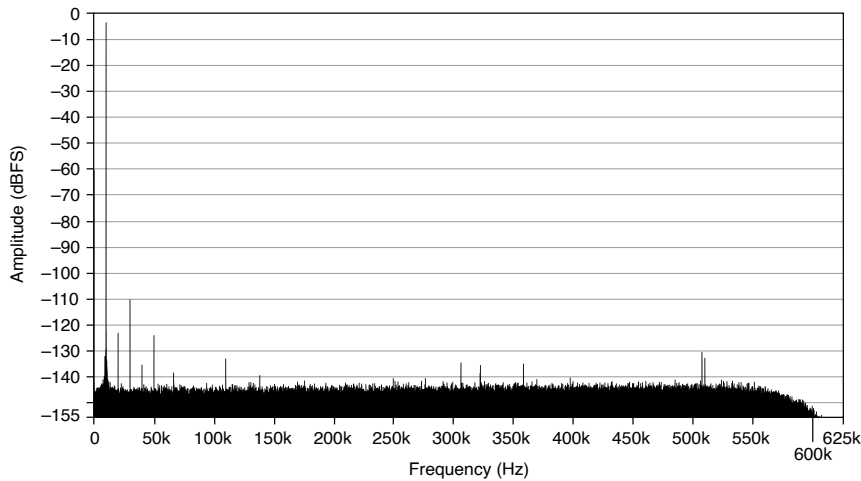
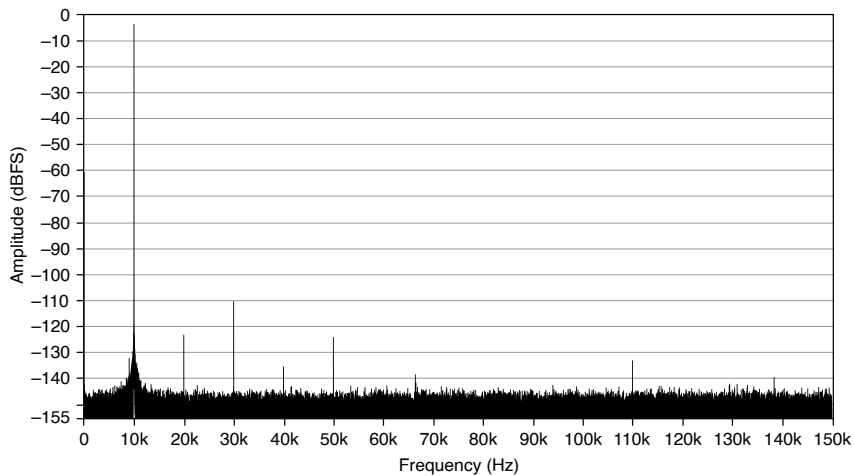
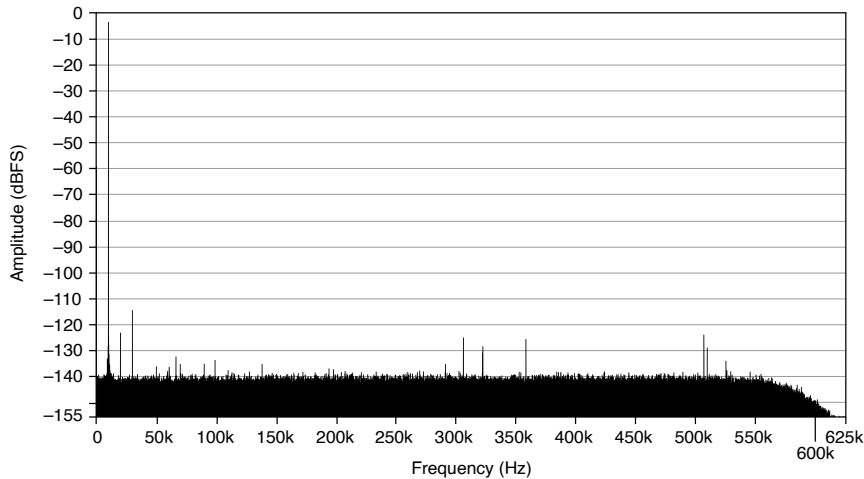
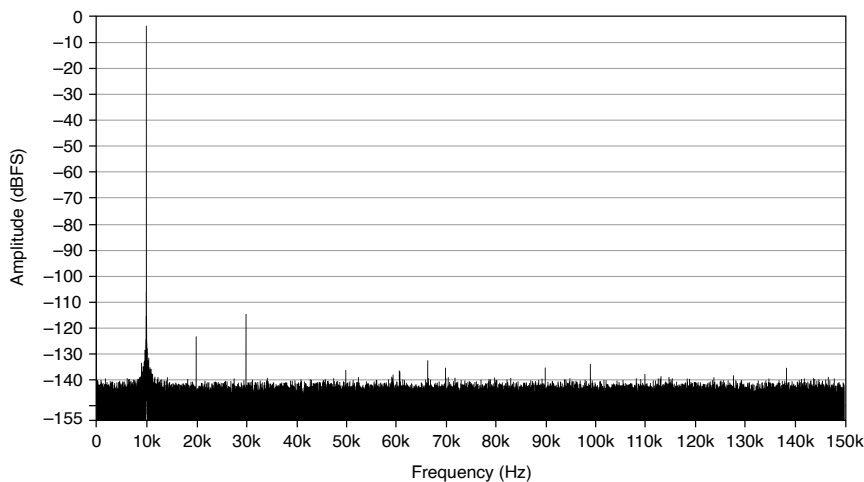
Figure 17. -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 5 V Range (150 kHz Bandwidth)**Figure 18.** -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 1 V Range (Full Bandwidth)**Figure 19.** -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 1 V Range (150 kHz Bandwidth)

Figure 20. -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 0.5 V Range (Full Bandwidth)**Figure 21.** -3 dBFS, 10 kHz Tone Acquired at 1.25 MSample/s, 0.5 V Range (150 kHz Bandwidth)

Spurious Free Dynamic Range (Voltage)

Range (V)	SFDR (dBC) ^{*, †, ‡}		
	$f_s = 51.2 \text{ kSample/s}$	$f_s = 204.8 \text{ kSample/s}$	$f_s = 1.25 \text{ MSample/s}$
10	100	100	100
5	100	100	100
1	100	100	94
0.5	100	100	88

* 1 kHz input tone, input amplitude is -3 dBFS.

Range (V)	SFDR (dBC) ^{*,†,‡}		
	$f_s = 51.2 \text{ kSample/s}$	$f_s = 204.8 \text{ kSample/s}$	$f_s = 1.25 \text{ MSample/s}$
[†] Differential configuration. [‡] Evaluation BW = 10 Hz to $0.4 f_s$			

Total Harmonic Distortion (THD), Balanced Source

Range (V)	THD (dBC) ^{*,†}				
	$f_s = 51.2 \text{ kSample/s}$		$f_s = 204.8 \text{ kSample/s}$		
	$f_{in} = 1 \text{ kHz}$	$f_{in} = 20 \text{ Hz to } 20 \text{ kHz}$	$f_{in} = 1 \text{ kHz}$	$f_{in} = 20 \text{ Hz to } 20 \text{ kHz}$	$f_{in} > 20 \text{ kHz to } 80 \text{ kHz}$
10, 5, 1, 0.5	-100	-100	-100	-98	-96
[*] Input amplitude is -3 dBFS. [†] Differential configuration.					

Range (V)	THD (dBC) ^{*,†}				
	$f_s = 1.25 \text{ MSample/s}$				
	$f_{in} = 1 \text{ kHz}$	$f_{in} = 10 \text{ kHz}$	$f_{in} = 20 \text{ Hz to } 20 \text{ kHz}$	$f_{in} > 20 \text{ kHz to } 50 \text{ kHz}$	$f_{in} > 50 \text{ kHz to } 100 \text{ kHz}$
10, 5, 1, 0.5	-100	-99	-98	-95	-90
[*] Input amplitude is -3 dBFS. [†] Differential configuration.					

Total Harmonic Distortion (THD), Unbalanced Source

Range (V)	THD (dBC) ^{*,†}				
	$f_s = 51.2 \text{ kSample/s}$		$f_s = 204.8 \text{ kSample/s}$		
	$f_{in} = 1 \text{ kHz}$	$f_{in} = 20 \text{ Hz to } 20 \text{ kHz}$	$f_{in} = 1 \text{ kHz}$	$f_{in} = 20 \text{ Hz to } 20 \text{ kHz}$	$f_{in} > 20 \text{ kHz to } 80 \text{ kHz}$
10	-100	-97	-100	-90	-85
5, 1, 0.5	-100	-100	-100	-97	-96

* Input amplitude is -3 dBFS.

† Pseudodifferential configuration.

Range (V)	THD (dBC) ^{*,†}				
	$f_s = 1.25 \text{ MSample/s}$				
	$f_{in} = 1 \text{ kHz}$	$f_{in} = 10 \text{ kHz}$	$f_{in} = 20 \text{ Hz to } 20 \text{ kHz}$	$f_{in} > 20 \text{ kHz to } 50 \text{ kHz}$	$f_{in} > 50 \text{ kHz to } 100 \text{ kHz}$
10	-100	-95	-90	-81	-74
5, 1, 0.5	-100	-98	-97	-92	-81

* Input amplitude is -3 dBFS.

† Pseudodifferential configuration.

Crosstalk, Input Channel Separation

Range (V)	Crosstalk (dBC) ^{*,†}	
	$f_{in} = 1 \text{ kHz}$	$f_{in} = 100 \text{ kHz}$
10, 5, 1, 0.5	-140	-100

Range (V)	Crosstalk (dBC) ^{*,†}	
	$f_{in} = 1 \text{ kHz}$	$f_{in} = 100 \text{ kHz}$
* Input amplitude is -1 dBFS.		
† Source impedance is $\leq 50 \Omega$		

Voltage Reference

DC level	4,096 V
Temperature coefficient	5 ppm/°C maximum
Time stability	20 ppm/1,000 hr

IEPE Excitation

Current settings	
OFF	0 mA
4 mA	4 mA minimum, 4.15 mA typical, 4.3 mA maximum
10 mA	9.7 mA minimum, 10 mA typical, 10.3 mA maximum
20 mA	19.4 mA minimum, 20 mA typical, 20.6 mA maximum

Each channel independently software-selectable.

Voltage compliance	22 V
--------------------	------



Note Use the following equation to make sure that your configuration meets the IEPE voltage compliance range: $\text{CommonMode} + \text{Bias} \pm \text{FullScale} + (\text{Excitation} \times 50 \Omega)$ must be 0 V to 22 V, where

CommonMode is the common-mode voltage seen by the input channel,
 Bias is the DC bias voltage of the sensor,
 FullScale is the AC full-scale voltage of the sensor, and
 Excitation is the selected excitation setting.

Sensor open detection ^{3[3]} (software-readable)	
4 mA	23 V
10 mA	22.5 V
20 mA	22 V
Sensor short detection ^[3] (software-readable)	
4 mA	1.3 V
10 mA	1 V
20 mA	0.5 V

3. Voltage between positive input (+) and negative input (-).

Channel input impedance with IEPE enabled	1.62 M Ω 250 pF, pseudodifferential
---	---

Transducer Electronic Data Sheet

Supports Transducer Electronic Data Sheet (TEDS) according to the IEEE 1451 Standard	Class I, all module inputs
--	----------------------------



Note For more information about TEDS, visit ni.com/r/rdteds.

Maximum load capacitance	10,000 pF
--------------------------	-----------

Voltage Excitation

Voltage settings	
OFF	0 V
10 V (fixed)	10 V
25 V (fixed)	25 V
Adjustment range	9.5 V to 11.98 V
Adjustment resolution	10 mV

Each channel independently software-selectable.

Load regulation ⁴	0.01%/mA
Output current (per channel)	25 mA minimum
Current limit detection (software-readable)	27.5 mA

Frequency Timebase Characteristics

Accuracy	
Using internal VCXO timebase	±50 ppm maximum
Using external timebase	Equal to accuracy of external timebase

Timing and Synchronization

Number of timing engines ⁵	3
Reference clock source	Onboard clock, backplane PXIe_CLK100
Intermodule ADC clock skew⁶	
$T_{tb} \pm 5^\circ\text{C}$	11 ns max ⁷

4. Excludes the effect of external cable resistance.

5. Two timing engines are dedicated to analog input and two timing engines are dedicated to analog output. Channels can be arbitrarily grouped and assigned to timing engines of the same channel type. Timing engines can be independently synchronized, started, and stopped. All timing engines must use the same reference clock source. Refer to the module user manual for more details on the assignment of timing engines.

Over full operating temperature range	20 ns max
---------------------------------------	-----------

Triggers

Analog trigger	
Purpose	Reference trigger only
Source	Any channel
Level	Full scale, programmable
Mode	Rising-edge or falling-edge with hysteresis, entering or leaving window
Resolution	24 bits
Digital trigger	
Purpose	Start or reference trigger
Source	PFI0, PXI_Trig<0..7>, PXI_Star, PXIe_DStar<A..B>
Polarity	Rising or falling edge, software-selectable

- Valid between PXIe-4480 modules installed in the same chassis. Between PXIe-4480 modules in different chassis, add the potential skew in the PXI_CLK10 clock distribution. Refer to the appropriate chassis documentation for its clock skew specifications.
- Listed accuracy is valid for 30 days following a timebase change. T_{tb} = ambient temperature at which the timebase source was last changed.

Minimum pulse width	100 ns for PXI_Trig<0..7>, 20 ns for others
---------------------	---

Output Timing Signals

Sources	Start Trigger Out, Reference Trigger Out, Sync Pulse Out
Destinations	PFI0, PXI_Trig<0..7>, PXIe_DStarC
Polarity	Software-selectable except for Sync Pulse Out (always active low)

PFI0 (Front Panel Digital Trigger)

Input	
Logic compatibility	3.3 V or 5 V
Input range	0 V to 5.5 V
V_{IL}	0.95 V maximum
V_{IH}	2.4 V minimum
Input impedance	10 k Ω
Overvoltage protection	± 10 V peak
Output	

Output range	0 V to 3.45 V
V _{OL}	0.33 V maximum at 5 mA
V _{OH}	2.8 V minimum at 5 mA
Output impedance	50 Ω
Output current	±5 mA maximum

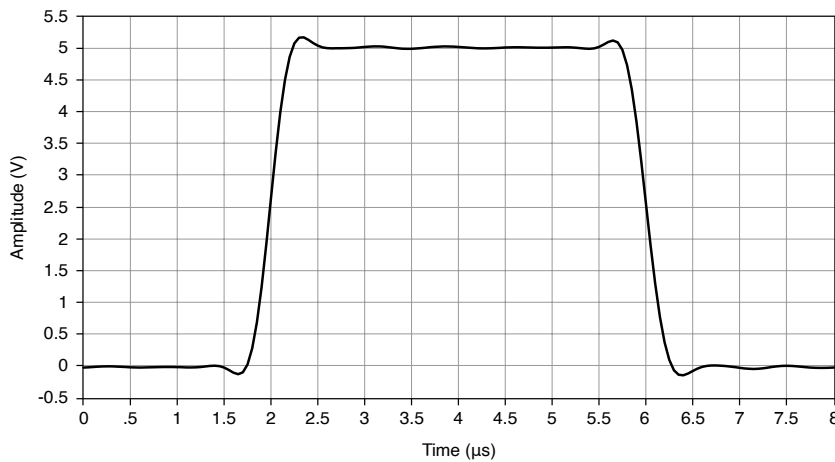
Time Domain Mode

Base sample rate	20 MSample/s
Sample rate decimation ⁸	Base sample rate divided by integers 1 to 15
Default FIR filter⁹	
Type	Equiripple low pass
Number of taps	35
Passband ripple	±5 mdB (DC to 800 kHz)

8. Time domain mode always operates and filters at the base sample rate of 20 MSample/s. Users may request a slower sample rate that the module will create by dropping samples to decimate down to the requested rate.
9. Digital filter is user-programmable. Refer to the **PXIe-4480/4481 User Manual** for more details.

Stopband attenuation	≥ 120 dB, $f_{in} \geq 3.9$ MHz
Effective number of bits (ENOB)	
10 V range	13.2
5 V range	13.5
1 V range	13.5
0.5 V range	13.1

Figure 22. Time Domain Step Response, 5 V Range, Sampled at 20 MSample/s



Note The measured step response is affected by both the fixed anti-aliasing analog filtering and the digital filter used. Signal measured for step response had a rise/fall time of less than 15 ns.

General Specifications

This section lists general specification information for the PXIe-4480.

Bus Interface

Form factor	x4 PXI Express peripheral module, Specification rev. 1.0 compliant
Slot compatibility	PXI Express or PXI Express hybrid slots
DMA channels	3, analog input

Power Requirements

Voltage (V)	Current (A), Maximum (Typical)
+3.3	2.0 (1.5)
+12	3.0 (2.5)

Physical

Clean the hardware with a soft, nonmetallic brush. Make sure that the hardware is completely dry and free from contaminants before returning it to service.

Dimensions (not including connectors)	16 cm x 10 cm (6.3 in. x 3.9 in.) 3U CompactPCI slot
Analog input connector	InfiniBand 12x
Digital trigger connector (PFI0)	SMB male
Front-panel LEDs	2 (Access, Active)

Weight	264 g (9.3 oz)
Measurement Category	1 ¹⁰



Caution Do not connect the product to signals or use for measurements within Measurement Categories II, III, or IV.



Attention Ne pas connecter le produit à des signaux dans les catégories de mesure II, III ou IV et ne pas l'utiliser pour effectuer des mesures dans ces catégories.



Caution Observe all instructions and cautions in the user documentation. Using the product in a manner not specified can damage the product and compromise the built-in safety protection.



Attention Suivez toutes les instructions et respectez toutes les mises en garde de la documentation d'utilisation. L'utilisation du produit de toute autre façon que celle spécifiée risque de l'endommager et de compromettre la protection de sécurité intégrée.

Environmental

Operating Environment

Ambient temperature range	0 °C to 55 °C (Tested in accordance with IEC 60068-2-1 and IEC 60068-2-2.)
---------------------------	--

10. Measurement Categories CAT I and CAT O are equivalent. These test and measurement circuits are not intended for direct connections to the MAINS building installations of Measurement Categories CAT II, CAT III, CAT IV.

Relative humidity range	10% to 90%, noncondensing (Tested in accordance with IEC 60068-2-56.)
Altitude	2,000 m (800 mbar)
Pollution degree	2

Indoor use only.

Storage Environment

Ambient temperature range	-40 °C to 71 °C (Tested in accordance with IEC 60068-2-1 and IEC 60068-2-2.)
Relative humidity range	5% to 95%, noncondensing (Tested in accordance with IEC 60068-2-56.)

Shock and Vibration

Operational shock	30 g peak, half-sine, 11 ms pulse (Tested in accordance with IEC-60068-2-27. Test profile developed in accordance with MIL-PRF-28800F.)
Random vibration	
Operating	5 Hz to 500 Hz, 0.3 g RMS
Nonoperating	5 Hz to 500 Hz, 2.4 g RMS (Tested in accordance with IEC-60068-2-64. Nonoperating test profile exceeds the requirements of MIL-PRF-28800F, Class 3.)

Calibration

External calibration interval	2 years
Warm-up time	15 minutes

Safety Compliance Standards

This product is designed to meet the requirements of the following electrical equipment safety standards for measurement, control, and laboratory use:

- IEC 61010-1, EN 61010-1
- UL 61010-1, CSA C22.2 No. 61010-1



Note For safety certifications, refer to the product label or the [Product Certifications and Declarations](#) section.

Electromagnetic Compatibility

This product meets the requirements of the following EMC standards for electrical equipment for measurement, control, and laboratory use:

- EN 61326-1 (IEC 61326-1): Class A emissions; Controlled immunity
- EN 55011 (CISPR 11): Group 1, Class A emissions
- EN 55022 (CISPR 22): Class A emissions
- EN 55024 (CISPR 24): Immunity
- AS/NZS CISPR 11: Group 1, Class A emissions
- AS/NZS CISPR 22: Class A emissions
- FCC 47 CFR Part 15B: Class A emissions
- ICES-001: Class A emissions



Note Group 1 equipment (per CISPR 11) is any industrial, scientific, or medical equipment that does not intentionally generate radio frequency

energy for the treatment of material or inspection/analysis purposes.



Note In the United States (per FCC 47 CFR), Class A equipment is intended for use in commercial, light-industrial, and heavy-industrial locations. In Europe, Canada, Australia and New Zealand (per CISPR 11) Class A equipment is intended for use only in heavy-industrial locations.



Note For EMC declarations and certifications, and additional information, refer to the **Online Product Certification** section.

CE Compliance

This product meets the essential requirements of applicable European Directives, as follows:

- 2014/35/EU; Low-Voltage Directive (safety)
- 2014/30/EU; Electromagnetic Compatibility Directive (EMC)

Product Certifications and Declarations


Refer to the product Declaration of Conformity (DoC) for additional regulatory compliance information. To obtain product certifications and the DoC for NI products, visit ni.com/product-certifications, search by model number, and click the appropriate link.

Environmental Management


NI is committed to designing and manufacturing products in an environmentally responsible manner. NI recognizes that eliminating certain hazardous substances from our products is beneficial to the environment and to NI customers.

For additional environmental information, refer to the **Engineering a Healthy Planet** web page at ni.com/environment. This page contains the environmental regulations and directives with which NI complies, as well as other environmental information not included in this document.

EU and UK Customers

-  **Waste Electrical and Electronic Equipment (WEEE)**—At the end of the product life cycle, all NI products must be disposed of according to local laws and regulations. For more information about how to recycle NI products in your region, visit ni.com/environment/weee.

电子信息产品污染控制管理办法（中国RoHS）

-  **中国RoHS**—NI符合中国电子信息产品中限制使用某些有害物质指令 (RoHS)。关于NI中国RoHS合规性信息，请登录 ni.com/environment/rohs_china。(For information about China RoHS compliance, go to ni.com/environment/rohs_china.)

NI Services

Visit ni.com/support to find support resources including documentation, downloads, and troubleshooting and application development self-help such as tutorials and examples.

Visit ni.com/services to learn about NI service offerings such as calibration options, repair, and replacement.

Visit ni.com/register to register your NI product. Product registration facilitates technical support and ensures that you receive important information updates from NI.

NI corporate headquarters is located at 11500 N Mopac Expwy, Austin, TX, 78759-3504, USA.